

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/766,779	<b>Applicant(s)/Patent under Reexamination</b> MC CALLISTER, RONALD DUANE
<b>Examiner</b> Emmanuel Bayard	<b>Art Unit</b> 2611	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner